Solar cell fabricated on welded thin flexible silicon

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Abstract We present a thin-film crystalline silicon solar cell with an AM1.5 efficiency of 11.5% fabricated on welded 50 μm thin silicon foils. The aperture area of the cell is 1.00 cm². The cell has an open-circuit voltage of 570 mV, a short-circuit current density of 29.9 mA cm⁻² and a fill factor of 67.6%. These are the first results ever presented for solar cells on welded silicon foils. The foils were welded together in order to create the first thin flexible monocrystalline band substrate. A flexible band substrate offers the possibility to overcome the area restriction of ingot-based monocrystalline silicon wafers and the feasibility of a roll-to-roll manufacturing. In combination with an epitaxial and layer transfer process a decrease in production costs can be achieved.

1 Introduction

Silicon solar cells are following the recipe of improving efficiency and reducing material usage to consolidate their position on the market. Thus silicon thin-film solar cells are in the focus of interest due to the low silicon usage as well as the potential lower production costs. In 2012, the porous silicon (PSI) layer transfer process has proved that high efficiency values can be obtained. Efficiency values of up to 19.1% (aperture area: 3.98 cm²) have been reached at a thickness of 43 μm by Brendel and co-workers [1, 2]. This result was even excelled by the company Solexel, who reported also a 43 μm thick solar cell but with an area of 156 mm × 156 mm based on a PSI layer transfer process with a world record efficiency of 20.1% (aperture area: 242.60 cm²) [3–5]. Reuse cycles of above 50 are already achieved without any degradation effects [4].

ZAE Bayern developed a method of producing a large-area substrate for solar cell production called “extended-monocrystalline-silicon-base-foil” (EMOSiB). This substrate offers the possibility of high efficiency solar cells while reducing the material usage at the same time. An illustration of the EMOSiB is depicted in Figure 1. This band substrate would be the first monocrystalline silicon band substrate, further details are published elsewhere [6–8]. In short, an endless thin and flexible band substrate of silicon is suggested as an epitaxial seed layer for the roll-to-roll production of crystalline solar cells. The lateral bonding of several thin single wafers to a band substrate are established by a laser welding process, for further details see [9, 10]. Other approaches for lateral bonding are rare, only one other concept exists, and is published by Werner et al. [11]. Within this concept the gap between two silicon wafers are closed by lateral epitaxy. No results have been published since it was introduced in 2001.

The EMOSiB itself has to be manufactured by thin silicon wafers grown as ingots. A low thickness of the joined foils is essential for sufficient flexibility of the resulting substrate. By using an epitaxial process combined with
2 Material and methods

2.1 Device fabrication

The process flow of the solar cell production is depicted in Figure 2 and started with 280 µm thick, 5 inch diameter float-zone grown silicon wafers with an orientation of (100), p-type, boron doped with a resistivity of 0.45–0.55 Ω cm. The wafers were laser cut into 25 mm × 25 mm pieces using a Nd:YVO₄ laser (Rofin-Sinar Laser GmbH, model: Power Line E20). The thickness of the pieces was decreased by etching in potassium hydroxide (KOH) solution to approx. 50 µm followed by a RCA cleaning using a system of Kufner Nassprozesstechnik GmbH. The KOH concentration was 22% and the solution was kept constantly at 85 °C.

Before the welding process began the silicon foils were placed on a specimen holder of fused quartz glass in a crucible furnace and the temperature was increased to 1015 °C in a nitrogen atmosphere. The laser beam was introduced through a fused quartz window in the furnace, for further details see [1]. The three silicon foils were keyhole welded to one silicon foil, two were placed in butt joint geometry and one in the middle at the back side of the other two as depicted in Figures 3 and 4. Further information about Keyhole welding are published elsewhere [9,10]. For welding a ytterbium single mode fiber laser model YLR-1000-SM made by the company IPG Photonics was used. This is a continuous wave laser with a wavelength of 1075 nm, a very high beam quality ($M^2 < 1.1$) and a maximum power of approx. 1000 W. Additionally a galvanometer scanner system with an objective focal length of 370 mm was used to focus and deflect the laser beam.

![Fig. 2. Process flow diagram for solar cells on top of keyhole welded silicon foils as prepared in this work.](image-url)
Ti 30 nm/Pd 30 nm/Ag 5 μm layers were formed by using shadow masks in an electron beam evaporator using a Pfeiffer Vacuum system model: Classic 570. A silicon nitride layer was deposited by plasma-enhanced chemical vapor deposition (PECVD) on the front side as antireflective coating (Roth & Rau GmbH, model: AK1000). A photograph of finished solar cells is depicted in Figure 4a.

2.2 Characterization

The sample was measured by an internally developed sun simulator at ZAE Bayern, the J-V curve was determined under AM1.5 illumination (1000 W/m²) produced by halogen lamps and solar cell temperature of 25 °C. The height of the lamps were aligned according to the short-circuit current of a calibration sample. The value of parallel resistance ($R_p$) was determined from the gradient between −0.9 V to −0.7 V of the dark J-V characteristic and for the series resistance ($R_s$) from the comparison of the dark J-V characteristic and AM1.5 characteristic of the solar cell at $V_{oc}$.

A reflectance (R) and external quantum efficiency (EQE) measurement was performed at the physics department of the University of Konstanz using a solar cell analysis system LOANA, fabricated by pv-tools GmbH. The data was corrected for grid shading by using the software Lassie 7.5 of the company pv-tools and the internal quantum efficiency ($IQE$) was calculated from the reflectance and the external quantum efficiency:

$$IQE = EQE/(1 - R).\quad (1)$$

3 Results and discussion

The solar cell was measured three times under the sun simulator in order to study the influences of the welded area of the solar cell. The first measurement was performed after the cell processing. Afterwards an additional laser edge isolation line #2 was applied to exclude the welded area from the active area of the solar cell electrically as depicted in Figure 4a. The efficiency increased by a factor of 55.5% in between the first measurement (aperture area: 3.24 cm²) and the second measurement (aperture area: 2.70 cm²). For the last measurement the solar cell was masked with an opening of 1.0 cm², which corresponded to the optimum size with regard to the front grid. The efficiency increased by a factor of 24.7% in between second and third measurement.

The champion solar cell produced on keyhole welded silicon foils achieved an efficiency of 11.5% at an aperture area of 1.00 cm², more details are stated in Table 1 and depicted in Figure 5. Determined values of the champion cell were $V_{oc} = 570$ mV, $J_{sc} = 29.9$ mA/cm², $R_s = 0.61$ Ohm cm² and $R_p = 8.81$ kOhm cm². The values of the shunt resistance and the series resistance were both reasonable for a one-sun solar cell and did not severely affect the measured cell efficiency. Due to the thin thickness of the silicon foils and the lack of front site texturing.
Table 1. Result of the three measurements of the champion solar cell on keyhole welded silicon foils (cell area $A$, fill factor $FF$, open-circuit voltage $V_{oc}$, short-circuit current density $J_{sc}$ and efficiency $\eta$) determined by an internal developed sun simulator under AM1.5 illumination and 25 °C solar cell temperature.

<table>
<thead>
<tr>
<th>Measurement</th>
<th>$A$ [$\text{cm}^2$]</th>
<th>$FF$ [%]</th>
<th>$V_{oc}$ [mV]</th>
<th>$J_{sc}$ [$\text{mA/cm}^2$]</th>
<th>$\eta$ [%]</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>3.24</td>
<td>45.4</td>
<td>571</td>
<td>22.9</td>
<td>5.9</td>
</tr>
<tr>
<td>2</td>
<td>2.70</td>
<td>56.0</td>
<td>582</td>
<td>28.3</td>
<td>9.2</td>
</tr>
<tr>
<td>3</td>
<td>1.00</td>
<td>67.6</td>
<td>570</td>
<td>29.9</td>
<td>11.5</td>
</tr>
</tbody>
</table>

The short-circuit current density was low. The fact that the efficiency was rising by excluding the welding area was attributed to changes within the silicon because of the welding process. Therefore, solar cells with a high efficiency can only be built on the unirradiated areas.

Reference solar cells were fabricated in the same way except for the first three manufacturing steps in the process flow (laser cutting, KOH etching and keyhole welding) on top of 280 $\mu$m thick float-zone grown silicon wafers. Nine cells with an aperture area of 4.00 cm$^2$ each were fabricated on a single wafer. The mean efficiency value was 10.9% and the top efficiency value 12.4%.

Reflectance and quantum efficiency measurements revealed high reflectance values below 500 nm and above 900 nm as depicted in Figure 6. These values were due to the absence of surface texturing on the front side. Values above 900 nm were due to the reflectance on the back side of the silicon foils. The $IQE$ measurement revealed high surface recombination velocity at the front and back side. Results of the back side were better than of the front side due to the BSF.

Using PC1D (Version 5.9) to simulate the champion solar cell and adjusting the model to the measured $IQE$ characteristics values of the front surface recombination velocity of $1.60 \times 10^6$ cm/s and the rear surface recombination velocity of $1.50 \times 10^4$ cm/s were determined. More details of the PC1D simulation model are illustrated in Table 2.

The performance data determined by the PC1D simulation of the champion solar cell ($V_{oc} = 589$ mV, $J_{sc} = 28.4$ mA/cm$^2$, $\eta = 12.6\%$) differed in comparison to the measured results. The open-circuit voltage as well as the efficiency was higher than the measured results and the short-circuit current density was lower. This discrepancy was attributed to the fact of unpassivated surfaces in the middle of the solar cell by stacking two silicon foils on top of each other in order to create a band substrate as illustrated in Figure 4b. In our case the active area of the solar cell was affected by stacking at measurement 1 up to 33.3%, measurement 2 up to 20.0% and measurement 3 up to 5.0%. Despite the surface the two foils were connected with each other at the welding points. This fact is not possible to simulate with a one dimensional software such as PC1D. An additionally issue was that maybe aluminum diffused too far into the silicon bulk material, which was observed sometimes during solar cell manufacturing. However, the measured $IQE$ value were low at high wavelength, this showed that the BSF did not work as designed. This fact was inserted in the simulation model by setting the 1st rear diffusion to a very low value. This value is not realistic for a BSF simulation, but in our case necessary to fit our simulated data on the measured data.

The results of the solar cells are low in comparison to the established standard silicon solar cells, but this was a proof of concept with a simple cell process. Thus, higher efficiencies are possible by applying state of the art techniques like surface passivation and front side texturing.
4 Conclusions

Flexible silicon foils were successfully welded together by keyhole welding. Solar cells at different locations of the welded sample were compared. For high efficiencies it is essential to exclude electrically the area directly hit by the welding laser e.g. by scribing the emitter. The best solar cell on 50 μm thin flexible silicon by keyhole welding reached an efficiency of 11.5% at an aperture area of 1.00 cm², with promising values of FF = 67.6%, $V_{oc} = 570$ mV and $J_{sc} = 29.9$ mA/cm² for a proof of concept. The process flow of the fabrication was simple without clean room environment, no front side texturing and surface passivation. Therefore, higher efficiencies are feasible by applying state of the art techniques. Further investigations with these techniques applied have to show the real potential of this concept.

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